# Application/Control No. 10/040,317 Examiner Johnny H. Hoang Applicant(s)/Patent Under Reexamination SERKH ET AL. Art Unit Page 1 of 1

# Notice of References Cited

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,243,881	09-1993	Hayashi, Takashi	477/45
	В	US-5,089,964	02-1992	Morishige et al.	701/51
	C	US-5,085,104	02-1992	Kouno et al.	477/40
	D	US-4,982,822	01-1991	Petzold et al.	192/3.58
	Е	US-4,458,318	07-1984	Smit et al.	701/51
	ιŁ	US-			
	G	US-			•
	π	US-			
	_	US-			
	٦	US-			
	К	US-			
	L	US-			
	М	US-			

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	z					
	0					
	Р					
	Q					
	R					
	s					
	Т	- 38. III				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	×	:•

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)